## Notice of References Cited Application/Control No. 10/663,481 Examiner Cheukfan Lee Applicant(s)/Patent Under Reexamination SATO ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,552,829	04-2003	Maciey et al.	358/509
*	В	US-6,181,442	01-2001	Ogura et al.	358/475
*	С	US-4,731,661	03-1988	Nagano, Fumikazu	358/509
*	D	US-6,545,777	04-2003	Amimoto, Mitsuru	358/509
*	E	US-6,084,692	07-2000	Ohtani et al.	358/509
*	F	US-5,625,470	04-1997	Ueta et al.	358/505
	G	US-			
	Н	US-			
	1	US-	:		
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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